R&S®MX0 5 Series OSCILLOSCOPE

Specifications

ROHDE & SCHWARZ Make ideas real



C

٢

Co

CONTENTS

Definitions Base unit	
	$ \ge \mathbb{N}($
Vertical system: analog channels	
Vertical system: digital channels	
Horizontal system	
Acquisition system	
High definition mode	
Trigger system	
Spectrum analysis	\sim
RF characteristics	
Waveform measurements	
Waveform math	
Digital voltmeter	
Display characteristics	
History and segmented memory	
Miscellaneous	
Input and output	
Seneral data	
Options	
R&S®MXO5-B1 mixed signal option	<u>`</u>
R&S®MXO5-B6 arbitrary waveform generator	>
R&S®MXO5-K31 power analysis	
R&S®MXO5-K36 frequency response analysis	
R&S®MXO5-K510 low speed serial buses	
R&S®MXO5-K520 automotive protocols	
Ordering information	
R&S®MXO5-K520 automotive protocols	

Definitions

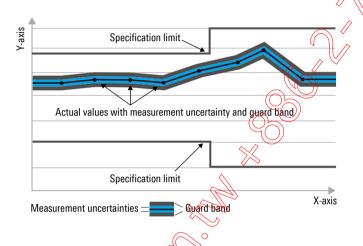
General

Product data applies under the following conditions:

- · Three hours storage at ambient temperature followed by 60 minutes warm-up operation
- Specified environmental conditions met
- · Recommended calibration interval adhered to
- · All internal automatic adjustments performed, if applicable

Specifications with limits

Represent warranted product performance by means of a range of values for the specified parameter. These specifications are marked with limiting symbols such as $\langle, \leq, \rangle, \geq, \pm$, or descriptions such as maximum, limit of, minimum. Compliance is ensured by testing or is derived from the design. Test limits are narrowed by guard bands to take into account measurement uncertainties, drift and aging, if applicable.



Non-traceable specifications with limits (n. trc.)

Represent product performance that is specified and tested as described under "Specifications with limits" above. However, product performance in this case cannot be warranted due to the lack of peasuring equipment traceable to national metrology standards. In this case, measurements are referenced to standards used in the Rohde & Schwarz laboratories.

Specifications without limits

Represent warranted product performance for the specified parameter. These specifications are not specially marked and represent values with no or negligible deviations from the given value (e.g. dimensions or resolution of a setting parameter). Compliance is ensured by design.

Typical data (typ.)

Characterizes product performance by means of representative information for the given parameter. When marked with <, > or as a range, it represents the performance met by approximately 80 % of the instruments at production time. Otherwise, it represents the mean value.

Nominal values (nom.)

Characterize product performance by means of a representative value for the given parameter (e.g. nominal impedance). In contrast to typical data, a statistical evaluation does not take place and the parameter is not tested during production.

Measured values (meas.)

Characterize expected product performance by means of measurement results gained from individual samples.

Uncertainties

Represent limits of measurement uncertainty for a given measurand. Uncertainty is defined with a coverage factor of 2 and has been calculated in tine with the rules of the Guide to the Expression of Uncertainty in Measurement (GUM), taking into account environmental conditions, aging, wear and tear.

Device settings and GUI parameters are designated with the format "parameter: value".

Non-traceable specifications with limits, typical data as well as nominal and measured values are not warranted by Rohde & Schwarz.

In time with the 3GPP standard, chip rates are specified in million chips per second (Mcps), whereas bit rates and symbol rates are specified in billion bit per second (Gbps), million bit per second (Mbps), thousand bit per second (kbps), million symbols per second (Msps) or thousand symbols per second (ksps), and sample rates are specified in million samples per second (Msample/s). Gbps, Mcps, Mbps, Msps, kbps, ksps and Msample/s are not SI units.

Base unit

Vertical system: analog channels

Input channels		4 channels or 8 channels			
nput impedance		50 Ω ± 1.5 %,			
		1 MΩ ± 1 % 12 pF (meas.)			
Analog bandwidth (–3 dB)	R&S®MXO 54, 4-channel instrument				
	at 50 Ω input impedance				
	R&S [®] MXO 5	≥ 350 MHz			
	R&S [®] MXO 5 with -B245 option	≥ 500 MHz			
	R&S [®] MXO 5 with -B2410 option	≥1 GHz			
	R&S [®] MXO 5 with -B2420 option	$\geq 2 \text{ GHz}^1$			
	at 1 MΩ input impedance, 4 channels				
	R&S [®] MXO 5	≥ 350 MHz (meas.)			
	R&S [®] MXO 5 with -B245 option	\geq 500 MHz (meas.)			
	R&S [®] MXO 5 with -B2410 option	\geq 700 MHz (meas.) ²			
	R&S [®] MXO 5 with -B2420 option	\geq 700 MHz (meas.) ²			
	R&S®MXO 58, 8-channel instrument				
	at 50 Ω input impedance				
	R&S [®] MXO 5	(≥ 100 MHz			
	R&S®MXO 5 with -B282	200 MHz			
	R&S®MXO 5 with -B283	≥ 350 MHz			
	R&S®MXO 5 with -B285 option	≥ 500 MHz			
	R&S [®] MXO 5 with -B2810 option) ≥ 1 GHz			
	R&S [®] MXO 5 with -B2820 option	≥ 2 GHz ³			
	at 1 MΩ input impedance, 4 channels				
	R&S®MXO 5	≥ 100 MHz (meas.)			
	R&S [®] MXO 5 with -B282	≥ 200 MHz			
	R&S [®] MXO 5 with -B283	≥ 350 MHz			
	R&S [®] MXO 5 with -B285 option	≥ 500 MHz (meas.)			
	R&S [®] MXO 5 with -B2810 option	≥ 700 MHz (meas.) ²			
	R&S [®] MXO 5 with -B2820 option	≥ 700 MHz (meas.) ²			
Bandwidth limits	max. –1.5 dB, min –4 dB	2 GHz, 1 GHz, 500 MHz, 350 MHz,			
		200 MHz, 100 MHz, 50 MHz, 20 MHz			
		(meas.)			
Rise/fall time (calculated)	10 % to 90 % at 50 Ω				
	R&S [®] MXO 54, 4-channel instrument				
	R&S®MXO 5	< 1.75 ns			
	R&S [®] MXO 5 with -B245 option	< 700 ps			
	R&S [®] MXO 5 with -B2410 option	< 350 ps			
	R&S [®] MXO 5 with -B2420 option	< 175 ps			
	R&S [®] MXO 58, 8-channel instrument	< 110 p3			
<	R&S [®] MXO 5	< 3.5 ns			
A	R&S®MXO 5 with -B282	< 1.75 ns			
\mathbb{A}	R&S®MXO 5 with -B283				
		< 1 ns			
	R&S [®] MXO 5 with -B285 option	< 700 ps			
	R&S [®] MXO 5 with -B2810 option	< 350 ps			
	R&S [®] MXO 5 with -B2820 option	< 234 ps			
rertical resolution		12 bit,			
		18 bit for high definition (HD) mode			
nput sensitivity	at 50 Ω	0.5 mV/div to 3 V/div,			
SINA >		entire analog bandwidth supported for al			
UTINK .		input sensitivities			
	at 1 MΩ	0.5 mV/div to 10 V/div,			
		entire analog bandwidth supported for al			
		input sensitivities			

¹² GHz analog bandwidth in interleave mode with 5 Gsample/s real-time sampling rate.

² With R&S[®]RT-ZP11 passive probe.

³ 2 GHz analog bandwidth only in interleave mode with 5 Gsample/s real-time sampling rate, when channels 5 to 8 are disabled.

DC gain accuracy		
	offset and position set to 0 V, after self-align input sensitivity > 5 mV/div	±1 % full scale
	input sensitivity > 5 mV/div	± 1 % full scale ± 1.5 % full scale
	$\leq 5 \text{ mV/div to} \geq 1 \text{ mV/div}$	
	input sensitivity 500 µV/div	±2.5 % full scale
Input coupling	at 50 Ω	DC
	at 1 MΩ	DC, AC
Maximum input voltage	at 50 Ω	5 V (RMS), 30 V (V _p)
Maximum input voltage	at 1 MΩ	300 V (RMS), 400 V (V _p),
		derates at 20 dB/decade to 5/V (RMS)
		above 250 kHz
	at 1 MΩ with R&S [®] RT-ZP11 passive	400 V (RMS), 1650 V (V),
	probe	300 V (RMS) CAT I
		for derating and details,
		see R&S [®] RT-Zxx Standard Probes
		specifications (PD 3607.3851.22)
Position range		±5 div
Offset range at 50 Ω	input sensitivity	
	120 mV/div to 3 V/div	$\pm (15 \sqrt{1-100})$ input sensitivity x position)
	33 mV/div to < 120 mV/div	\pm (7 V – input sensitivity × position)
	0.5 mV/div to < 33 mV/div	(2 V/→ input sensitivity × position)
Offset range at 1 MΩ	input sensitivity	
-	800 mV/div to 10 V/div	<u></u> ±290 √
	80 mV/div to < 800 mV/div	±50 V
	0.5 mV/div to < 80 mV/div	\pm (5 V – input sensitivity × position)
Offset accuracy	\square	$\pm (0.35 \% \times \text{net offset} +$
,		$0.5 \text{ mV} + 0.1 \text{ div } \times \text{ input sensitivity};$
	j – Ž	(net offset =
	▲	offset – position × input sensitivity)
DC measurement accuracy	after adequate suppression of	±(DC gain accuracy ×
	measurement noise using high definition	reading - net offset
	(HD) mode or waveform averaging or a	+ offset accuracy)
	combination of both	
Channel-to-channel isolation	input frequency inside instrument bandwidth	> 60 dB (1:1000)
	ο IJ	

At 50 Ω	Input	Analog bandw	idth (–3 dB)				
(meas.)	sensitivity	100 MHz	200 MHz	350 MHz	500 MHz	1 GHz	2 GHz
	0.5 mV/div	19 µV	26 µV	33 µV	39 µV	66 µV	111 µV
	1 mV/div	24 µV	33 µV	42 µV	51 µV	85 µV	141 µ¥
	2 mV/div	25 µV	35 µV	44 µV	53 µV	89 µV	146 µV
	5 mV/div	34 µV	46 µV	59 µV	71 µV	116 µV	182 µV
	10 mV/div	66 µV	89 µV	115 µV	138 µV	226 µV	350 µV)
	20 mV/div	134 µV	181 µV	233 µV	280 µV	461 µV	71⁄3 µV
	50 mV/div	324 µV	436 µV	563 µV	677 μV	1.12 mV	1,78 mV
	100 mV/div	610 µV	815 µV	1.05 mV	1.26 mV	2.08 mV	3.25 mV
	200 mV/div	1.26 mV	1.69 mV	2.17 mV	2.60 mV	4.31 mV	6.74 mV
	500 mV/div	4.21 mV	5.54 mV	6.94 mV	8.21 mV	12.93 m	18.63 mV
	1 V/div	6.88 mV	9.20 mV	11.71 mV	14.02 mV	22.57 mV	32.89 mV
	2 V/div	11.45 mV	15.21 mV	19.45 mV	23.21 mV	37.85 mV	54.59 mV
	3 V/div	15.77 mV	20.78 mV	26.54 mV	31.71 mV	51.80 mV	73.68 mV
At 1 MΩ	Input	Analog bandw	idth (–3 dB)				
(meas.)	sensitivity	100 MHz	200 MHz	350 MHz	500 MHz (700 MHz	
	0.5 mV/div	35 µV	40 µV	46 µV	54 µV 🧷 🖉	85 μV	
	1 mV/div	36 µV	42 µV	49 µV	57 µV	89 µV	
	2 mV/div	38 µV	45 µV	54 µV	64 µV	101 µV	
	5 mV/div	47 μV	58 µV	77 μV	92 µV 1	141 μV	
	10 mV/div	68 μV	89 µV	126 μV	152,4	229 μV	
	20 mV/div	120 μV	161 μV	235 µV	285 JUV	428 μV	
	50 mV/div	297 µV	401 µV	592 µV	√ 1/9 μV	1.08 mV	
	100 mV/div	678 µV	892 µV	1.25 mV	1.47 mV	2.16 mV	
	200 mV/div	1.21 mV	1.62 mV	2.33 mV	2.77 mV	4.09 mV	
	500 mV/div	2.88 mV	3.88 mV	5.68 mV	6.76 mV	10.01 mV	
	1 V/div	6.11 mV	8.08 mV	11.54 m	13.56 mV	18.51 mV	
	2 V/div	11.42 mV	15.20 mV	22.04 mV	25.98 mV	35.39 mV	
	5 V/div	29.10 mV	38.75 mV	56.46 mV	66.60 mV	90.40 mV	
	10 V/div	44.33 mV	58.62 mV	85.77 mV	101.12 mV	137.86 mV	

ABB MV ABB MV

⁴ HD mode active for bandwidth ≤ 500 MHz.

Vertical system: digital channels

Input channels		16 logic channels (D0 to D15)
Arrangement of input channels		arranged in two logic probes with
		8 channels each, assignment of the logic
		probes to the channels (D0 to D7 and D8)
		to D15) is displayed on the probe
Input impedance		100 kΩ ± 2 % ~4 pF (meas) at probe
		tips
Maximum input frequency	signal with minimum input voltage swing	400 MHz (meas.)
	and hysteresis setting: normal	
Maximum input voltage		±40 V (V _p)
Minimum input voltage swing		500 mV (V _{pp}) (meas,)
Threshold groups		D0 to D3, D4 to D7, D8 to D11 and
		D12 to D15
Threshold level	range	±8 V in 25 mV steps
	predefined	CMOS 5.0 V, CMOS 3.3 V, CMOS 2.5 V,
		TTL, ECL, PECL, LVPECL
Threshold accuracy	threshold level between ±4 V	$\pm (100 \text{ mV} + 3\% \text{ of threshold setting})$
Comparator hysteresis		normal, robust, maximum
Horizontal system		
i onzoniai system		$\sim \langle \bigcirc \rangle$

Horizontal system

ionzontal system		
Timebase range		selectable between 200 ps/div and 10000 s/div,
		time per div settable to any value with range
Deskew range (channel deskew)	between analog channels	±100 ns
Deskew range (onarmer deskew)	between digital channels	±100 ns
Reference position		0 % to 100 % of measurement display
		area
Horizontal position range (trigger offset	max.	+(memory depth/current sampling rate
range)	min.	–5000 s
Modes	°	normal
Channel-to-channel skew	between analog channels	< 100 ps (meas.)
	between digital channels	< 500 ps (meas.)
Timebase accuracy	after delivery/calibration, at +23 °C	±0.2 ppm
,	during calibration interval	±1 ppm
Delta time accuracy	corresponds to time error between two	±(0.20/real-time sampling rate +
	edges on same acquisition and channel;	timebase accuracy × reading) (peak)
	signal amplitude greater than 5 divisions,	(meas.)
	measurement threshold set to 50 %,	
	vertical gain 10 mV/div or greater;	
	rise time lower than four sample periods;	
AND	2 0) 0)	

Acquisition system

Sampling rate	analog channels (real time)	max. 5 Gsample/s on 4 channels, max. 2.5 Gsample/s on 8 channels
	analog channels (interpolated)	max. 5 Tsample/s
	digital channels	max. 5 Gsample/s on each channel
Waveform acquisition rate	max.	> 4 500 000 waveforms/s
Trigger rearm time	min.	< 21 ns
Memory depth ⁵	standard	
	analog channels only	R&S [®] MXO 58, 8-channel instrument: max. 500 Mpoints with 8 active channels (single capture), max. 500 Mpoints with 4 active channels (run continuous); R&S [®] MXO 54, 4-channel instrument: max. 500 Mpoints (single capture and run continuous)
	digital channels only (MSO)	max. 500 Mooints with 16 digital channels (single capture), max. 500 Mooints with 8 digital channels (run continuous)
	mix analog and digital	(max 500 Mpoints with 2 analog and 8 digital channels (single capture), max. 250 Mpoints with 2 analog and 8 digital channels (run continuous)
	with R&S®MXO5-B110 memory option	
	analog channels only	max. 1 Gpoints with 4 active channels (single capture), max. 1 Gpoints with 2 active channels
	digital channels only (MSQ)	(run continuous) max. 1 Gpoints with 8 digital channels
		(single capture), max. 500 Mpoints with 8 digital channels (run continuous)
	mix analog and digital	max. 500 Mpoints with 2 analog and 8 digital channels (single capture),
		max. 250 Mpoints with 2 analog and 8 digital channels (run continuous)
	math	
	with 1 active math	max. 87.5 Mpoints
	with 2 active math	max. 42.5 Mpoints
	with 2 active math	max. 20 Mpoints
	with 2 active math	max. 10 Mpoints
Acquisition modes	sample	middle sample in decimation interval
~	peak detect	largest and smallest sample in decimation interval
	average	average value of samples in decimation interval
	number of averaged waveforms	2 to 16 777 215
- Alexandre	envelope	envelope of acquired waveforms
Sampling modes	real-time mode	max. sampling rate set by digitizer
Skilaa	interpolated time	enhancement of sampling resolution by interpolation; max. sampling rate is 5 Tsample/s
Interpolation modes		linear, sin(x)/x, sample & hold
Fast segmentation mode	visualization	uisition memory without interruption due to
	max. real-time waveform acquisition rate min. blind time between consecutive acquisitions	> 4 600 000 waveforms/s < 21 ns

⁵ The maximum available memory depth depends on the bit resolution of the acquired data and, therefore, on the acquisition system settings such as decimation mode, use of waveform arithmetics or high definition (HD) mode. Interleave channels of the R&S®MXO 58 are on C1 and C5, C2 and C6, C3 and C7 as well as C4 and C8. For the R&S®MXO 54, all 4 channels run with 5 Gsample/s and maximum bandwidth.

 \diamond

High definition mode

General description	digital filtering, leading to reduced n	The high definition mode increases the bit resolution of the waveform signal by using digital filtering, leading to reduced noise. Because of the digital trigger concept of the R&S®MXO 5, signals with increased numeric resolution are used as the input for triggering.	
Numeric resolution	bandwidth, at 5 Gsample/s	bit resolution	
	1 kHz to 10 MHz	18 bit	
	100 MHz	16 bit	
	200 MHz	15 bit	
	500 MHz	14 bit	
Real-time sampling rate	all models	max. 2.5 Gsample/s on 4 channels, max. 1.25 Gsample/s on 8 channels	

Trigger system

Trigger sources		analog channels (C1 to C8),
		digital channels (D0 to D15),
		trigger input, line trigger, serial bus
Trigger level range		±5 div from center of screen
Trigger modes		auto, pormal, single, n single
Trigger sensitivity		0,0001 div, from DC to instrument
		bandwidth for all vertical scales, user
		adjustable
Trigger jitter	full-scale sine wave of frequency	set to 1 ps (RMS) (meas.)
	-3 dB bandwidth	(\mathcal{G})
Coupling mode	standard	same as selected channel
	HF reject	cutoff frequency selectable from 1 kHz to
	•	500 MHz
	LF reject	attenuates frequencies < 50 kHz
Trigger hysteresis	modes	auto (default setting) or manual
	adjustment resolution	0.0001 div, from DC to instrument
		bandwidth for all vertical scales
Holdoff range	time	100 ns to 10 s, fixed and random

Main trigger modes		
Edge	triggers on specified edge (positive, negative or either) and level	
Glitch	triggers on glitches of positive, negative or either polarity that are shorter or longer t specified width	
	glitch wigth	200 ps to 1000 s
Width	triggers on positive or negative pulse of specified width; width can be shorter, longer inside or outside a specified range	
	pulse width	200 ps to 1000 s
Runt	triggers on pulse of positive, negative or ei fails to cross a second threshold before cro can be arbitrary, shorter, longer, inside or runt pulse width	
Window	triggers when signal enters or exits a specified voltage range; triggers also when signal stays inside or outside the voltage range for a specified period of time	
Timeout	triggers when signal stays high, low or unchanged for a specified period of time	
	timeout	0 ps to 1000 s
Interval	triggers when time between two consecutiv	ve edges of same slope (positive or
Shaa	negative) is shorter, longer, inside or outside a specified range	
SLUII/	interval time	200 ps to 1000 s
Slew rate	triggers when the time required by a signal	l edge to toggle between user-defined upper
	and lower voltage levels is shorter, longer,	inside or outside a specified range; edge
	slope may be positive, negative or either	
	toggle time	0 ps to 1000 s

Advanced trigger modes		
Serial bus trigger	optional	see dedicated triggering and decoding
		options
Trigger input	input impedance	50 Ω (meas.) or
		1 MΩ (meas.) 11 pF (meas.)
	max. input voltage at 50 Ω	30 V (V _p)
	max. input voltage at 1 M Ω	300 V (RMS), 400 V (V _p),
		derates at 20 dB/decade to 5 V (RMS)
		above 250 kHz
	trigger level	±5 V
	sensitivity	
	input frequency ≤ 500 MHz	300 mV (V _{pp}) (meas.)
	input coupling	AC, DC (50 Ω and 1 M Ω)
	trigger filter	HF reject (attenuates > 50 kHz),
		LF reject (attenuates < 50 kHz),
		noise reject
	trigger modes	edge (positive, negative or either)
Trigger output	functionality	A pulse is generated for each event
		triggering signal acquisition.
	output voltage	0 V to 5 V (nom.) at high impedance;
		0 V to 2.5 V (nom.) at 50 Ω
	pulse width	selectable between 16 ns and 50 ms
	pulse polarity	low active or high active
	output delay	depends on trigger settings

Spectrum analysis

General description	Spectrum analysis allows up to four signal	
Spectrum	sources	channel 1 to channel 8
	setup parameters	center frequency, frequency span,
		resolution bandwidth (automatic or
		manual), gate position, gate width, vertical
		scaling, vertical position
	scaling	dBm, dBV, dBµV, V (RMS)
	span	1 Hz to 1.8 GHz ⁶
	resolution bandwidth (RBW)	$(span/4) \ge RBW \ge (span/6000)$
	windows (())	flat top, Hanning, Hamming, Blackman,
		rectangular, Kaiser Bessel, Gaussian
	trace types	normal, max. hold, min. hold, average
	max. real-time waveform acquisition rate	> 40 000 waveforms/s
Gate	delimits the display region used for spectru	m analysis
Peak list	The values in the peak list are also shown	in the diagram to allow easy correlation.
Sta		

⁶ The stop frequency depends on the analog bandwidth of the instrument.

RF characteristics

Sensitivity/noise density	at 1 GHz	–160 dBm (1 Hz) (meas.)
	(measurement of the power spectral	
	density at 1 GHz at input sensitivity	
	2 mV/div, corresponding to -30 dBm input	
	range of the oscilloscope, using spectrum	
	analysis with center frequency 1 GHz,	
	span 500 kHz, RBW 3 kHz)	
Noise figure	at 1 GHz	14 dB (meas.)
Noise lights	(calculated based on the noise power	
	density above)	
Dynamic range	measured for a 1 GHz input carrier with	106 dB (meas.)
Bynamie range	level –3 dBm at input of oscilloscope,	
	using spectrum analysis with center	
	frequency 1 GHz,	
	span 2 MHz, RBW 400 Hz at +20 MHz	
	from center frequency	
Absolute amplitude accuracy	0 Hz to 1.2 GHz	±1 dB (meas.)
Spurious-free dynamic range	measured for a 250 MHz input carrier with	
(excluding harmonics)	level –3 dBm at input sensitivity	05 dBc (meas.)
(excluding namonics)	50 mV/div, using spectrum analysis with	
	center frequency 900 MHz, span 1.8 GHz,	
	RBW 300 kHz	
Casard have an in distantion		
Second harmonic distortion	measured for a 250 MHz input carrier with	60 dBc (meas.)
	level –3 dBm at input sensitivity	
	50 mV/div, using spectrum analysis with	
	center frequency 900 MHz, span 1.8 GHz,	
	RBW 300 kHz	
Third harmonic distortion	measured for a 250 MHz input carrier with	–59 dBc (meas.)
	level –3 dBm at input sensitivity	
	50 mV/div, using spectrum analysis with	
	center frequency 900 MHz, span 1.8 GHz, RBW 300 kHz	

Waveform measurements

Automatic measurements	measurements on acquired wavefor	ms amplitude, high, low, maximum, minimum,
Automatic measurements	(input channels), math waveforms,	peak-to-peak, mean, RMS, sigma,
	reference waveforms	positive overshoot, negative overshoot
		area, rise time, fall time, positive pulse
		width, negative pulse width, period
		frequency, positive duty cycle, negative
		duty cycle, delay, phase, burst width,
		pulse count, edge count, pulse train,
		positive switching, negative switching,
		cycle area, cycle mean, cycle RMS, cycle
		sigma, setup, hold, setup/hold time,
		setup/hold ratio/slew rate rising, slew rate
		falling, delay to trigger
	gate	delimits the display region evaluated for
		automatic measurements
	reference levels	user-configurable vertical levels define
		support structures for automatic
		measurements
	statistics	displays maximum, minimum, mean,
		standard deviation and measurement
		count for each automatic measurement
	number of active measurements	24
Cursor measurements	available cursors	up to four cursor sets on screen, each set
		with two horizontal and two vertical
		cursors
	target waveforms	acquired waveforms (input channels),
	A	math waveforms, reference waveforms,
	anaroting modes	XY diagrams vertical measurements, horizontal
	operating modes	measurements, or both;
		vertical cursors either set manually or
		locked to waveform

Waveform math

General features	number of math equations	up to 8
	number of reference waveforms	up to 8
	sources	channel 1 to 8, math waveforms 1 to 8, reference waveforms 1 to 8
Functions	operators	add, subtract, multiply, divide, absolute value, square, square root, integrate, differentiate, log_{10} , log_e , log_2 , reciprocal, invert, lowpass, highpass, rescale (a • x + b)
	Gilters	lowpass, highpass
	filter types	Gaussian, rectangular
	gate	delimits the display region used for waveform math

 $\langle \rangle$

Digital voltmeter

Accuracy		related to channel settings of voltmeter
SUM/		source
Measurements		DC, DC RMS, AC RMS
Sources	R&S [®] MXO 54	C1, C2, C3, C4
	R&S [®] MXO 58	C1, C2, C3, C4, C5, C6, C7, C8
Number of measurements		up to 4
Resolution		up to 6 digits
Bandwidth		up to 20 MHz

Display characteristics

Diagram types	Yt, zoom, spectrum	
Display configuration (waveform	The display area can be split into separate diagram areas by dragging and dropping signal	
layout)	icons. Each diagram can hold any number of signals. Diagrams can be stacked on top of each other and later accessed via dynamic tabs (Tab 1, etc.)	
Signal icons	Each active waveform is represented by a signal icon on the signal bar; the signal icon displays the individual vertical and acquisition settings.	
Toolbar	Enables quick access to important tools; allows to set the most common parameters directly in a simple menu and gives access to more detailed parameters in the main menu. User-defined selection of tools in the toolbar.	
Upper menu bar	Displays trigger, horizontal and acquisition system settings; allows quick access to these settings.	
Main menu	Provides access to all instrument settings in a compact menu structure.	
Axis label	The x-axis and y-axis are labeled with values and physical unit.	
Diagram label	Diagrams can be individually labeled with a descriptive, user-defined name.	
Diagram layout	The grid, crosshair, axis labeling and diagram labeling can be switched on and off separately.	
Persistence	50 ms to 50 s, or infinite	
Zoom	vertical and horizontal; touch interface simplifies resize and drag operations on zoom window	
Signal colors (waveform coding)	predefined or user-defined color tables for persistence display	
History and segment	ed memory	
A 1.1.1		

History and segmented memory

, ,					
Acquisition memory	automatic		of segment size and		
	manual		ng of segment size ar		
Memory segmentation	function		s for the acquisition		
	number of segments	record length	segments 7	total memory	
			(up to)		
		1 kpoints	1 048 575	1.049 Gpoints	
		2 kpoints	1 048 575	2.097 Gpoints	
		5 kpoints	1 048 575	5.243 Gpoints	
		10 kpoints	1 048 575	10.486 Gpoints	
		20 kpoints	1 048 575	20.972 Gpoints	
		50 kpoints	1 048 575	52.429 Gpoints	
		100 kpoints	1 048 575	104.858 Gpoints	
		200 kpoints	1 048 575	209.715 Gpoints	
		500 kpoints	1 048 575	524.288 Gpoints	
	$\widehat{}$	1 Mpoints	1 048 575	1048.575 Gpoints	
		2 Mpoints	524 287	1048.574 Gpoints	
		5 Mpoints	262 143	1310.715 Gpoints	
		10 Mpoints	131 071	1310.710 Gpoints	
		20 Mpoints	65 535	1310.700 Gpoints	
		50 Mpoints	32 767	1638.350 Gpoints	
		100 Mpoints	16 383	1638.300 Gpoints	
		200 Mpoints	9 361	1872.200 Gpoints	
		500 Mpoints	4 095	2047.500 Gpoints	
		1 Gpoints	2 113	2113.000 Gpoints	
	Segmentation is avail	ilable for all analog ar	nd logic channels, pro	tocol decoding and spectrum	
	analysis.	0	0	0 1	
Fast-segmented mode	continuous recording	of waveforms in acq	uisition memory witho	out interruption due to	
	visualization; for blind	d time between conse	ecutive acquisitions, s	ee Acquisition system	
History mode	function		The history mode	e is an always-on function and	
×	2		provides access to past acquisitions in the		
SKINN A			segmented mem	ory.	
7/5/77	timestamp resolution	timestamp resolution		1 ns	
	history player			replays the recorded waveforms; repetition	
			possible; adjustable speed; manual switching to next/previous segment; numerical segment		
			number input		
	analyze options			ents, average all segments,	
			envelope all segr	ments	

INV ~					

⁷ With R&S®MXO5-B110 memory option. The maximum number of segments depends on the number of active channels and the bit resolution of the acquired data and, therefore, on the acquisition system settings such as decimation mode, use of waveform arithmetics or high definition (HD) mode. The maximum number of segments without the R&S®MXO5-B110 memory option is limited to 10 000.

Miscellaneous

Remote control	web interface	full operation of the instrument's touch interface, keys and multifunction wheel via
		web browser
	VNC	control of the instrument through virtual
		network computing
	SCPI	standard instrument programming) interface through VISA
	WebDAV	support for the web distributed authoring and versioning (WebDAV) protocol, which provides secure access through an application proxy
Languages	available languages for the user interface	English, German, French, Simplified Chinese, Traditional Chinese, Japanese, Russian, Spanish, Italian, Portuguese, Korean, Czech, Polish
	online help on the instrument	English

Input and output

Front		
Channel inputs		BNC) for details, see Vertical system
	probe interface	auto detection of passive probes,
		Rohde & Schwarz active probe interface
Trigger input		BNC; for details, see Trigger system
	probe interface	auto detection of passive probes
Waveform generator outputs		BNC; for details, see R&S [®] MXO5-B6,
(requires R&S [®] MXO5-B6 option)	~	waveform generator,
		demo lugs and GND lug
Digital channel inputs	D15 to D8, D7 to D0	interface for R&S®RT-ZL04 logic probe
Probe compensation output	signal shape	rectangle, $V_{low} = 0 V$, $V_{high} = 3.3 V$
		amplitude 3.3 V (V_{pp}) ± 5 % (meas.)
	frequency	1 kHz ± 1 % (meas.)
USB interfaces		3 x USB 3.1 Gen 1 ports, type A plug

Trigger out			BNC;
			for details, see Trigger system
USB interface			1 × USB 3.1 Gen 1 port, type B plug
Reference input	C	connector	BNC
	i	mpedance	50 Ω (nom.)
	Q	nput frequency	10 MHz (±20 ppm)
	and the second s	ensitivity	\geq -10 dBm into 50 Ω ,
			≤ 10 dBm at 10 MHz
Reference output	<u> </u>	connector	BNC
	i (^a)	mpedance	50 Ω (nom.)
		output signal	10 MHz (specified with timebase
			accuracy), 8 dBm (nom.)
Security slot			for standard Kensington style lock
VESA mount		via R&S [®] MXO5-Z7 VESA adapter	VESA compatibility mounting interface,
			100 mm × 100 mm pattern size, accordir
No la	<u>^</u>		FDMI MIS-D, up to 14 kg with M4x10
SDM			screws
	>		
Right side			
			connected to ground
Ground jack			
Ground jack			2 × USB 3.1 Gen 1 ports, type A plug RJ-45 connector,
Ground jack USB interfaces			2 × USB 3.1 Gen 1 ports, type A plug RJ-45 connector,
Ground jack USB interfaces	e		2 × USB 3.1 Gen 1 ports, type A plug

General data

Display	type	15.6" LC TFT color display with capacitiv
		touchscreen
	resolution	1920 × 1080 pixel (Full HD)
Temperature		
Temperature range	operating temperature range	0 °C to +50 °C
	storage temperature range	-40 °C to +70 °C
		in line with MIL-PRF-28800F section
		4.5.5.1.1.1 class 3 tailored to +45 °C for
		operation
Climatic resistance	damp heat	+25 °C/+50 °C at 85 % relative humidity
		cyclic,
		in line with JEC 60068-2-30
Altitude		
Operating		up to 3000 m above sea level
Nonoperating		up to 4600 m above sea level
Mechanical resistance		
Vibration	sinusoidal	5 Hz to 150 Hz, max. 1.8 g at 55 Hz;
		0.5 g from 55 Hz to 150 Hz,
		() in line with EN 60068-2-6
	~	10 Hz to 55 Hz,
		in line with MIL-PRF-28800F, section
	~ ~ ~	4.5.5.3.2, class 3
	random	8 Hz to 500 Hz,
		acceleration 1.2 g (RMS),
	ST S	in line with EN 60068-2-64
		5 Hz to 500 Hz,
	○ ○	acceleration 2.058 g (RMS),
		in line with MIL-PRF-28800F,
		section 4.5.5.3.1, class 3
Shock		40 g shock spectrum,
		in line with MIL-STD-810G,
		method no. 516.6, procedure I
		30 g functional shock, half sine,
		duration 11 ms,
		in line with MIL-PRF-28800F,
		section 4.5.5.4.1
		Section 4.5.5.4.1
Electromagnetic compatibility (EN		
RF emissions		in line with CISPR 11/EN 55011 group 1
~	1 million	class A (for a shielded test setup);
		the instrument complies with the emission
		requirements stipulated by EN 55011,
		EN 61326-1 and EN 61326-2-1 class A,
lan -		making the instrument suitable for use ir
		industrial environments
Immunity		in line with IEC/EN 61326-1 table 2,
		immunity test requirements for industrial
I HIL		environment ⁸
Certifications		VDE, _C CSA _{US} , KC
Calibration interval		1 year
Y///2		

 8 Test criterion is displayed noise level within ±1 div for an input sensitivity of 5 mV/div.

Power supply		
AC supply		100 V to 240 V ± 10 % at
		50 Hz to 60 Hz and 400 Hz ± 5 %,
		max. 4 A to 1.4 A,
		in line with MIL-PRF 28800F, section 3.5
Power consumption	standby mode	1.6 W
	all channels on	180 W (typ.)
	max.	360 W
Safety		in line with IEC 61010-1,
		IEC 61010-2-030,
		CAN/CSA-C22.2 no. 61010-1-12,
		UL 61010-1,
		CAN/CSA C22.2 no. 61010-2-030-18

		CAN/CSA C22.2 no 61010-2-030-18
Mechanical data		
Dimensions	W×H×D	445 mm × 314 mm × 153 mm
Dimensions	WAILAD	$(17.51 \text{ in } \times 12.36 \text{ in } \times 6.02 \text{ in})$
Weight	without options, nominal	9.0 kg (19.85 lb)
Rackmount height	with R&S [®] ZZA-MXO5 rackmount kit	8 HU
6 Rohde & Schwarz R&S®MXO 5 Seri		

Options

R&S®MXO5-B1 mixed signal option

Mixed signal capability is a standard functionality of the R&S®MXO 5 Series oscilloscopes. The R&S®MXO5-B1 mixed signal option provides 16 digital channels with two R&S®RT-ZL04 probes.

R&S®MXO5-B6 arbitrary waveform generator

Arbitrary function/waveform generator, 2 analog channels

General	
Output channel	2 channels
Vertical resolution	16 bit
Operating modes	function generator, arbitrary waveform
	generator, modulation, frequency sweep
	\square

Function generator	output of predefined waveforms	
Sample rate		625 Msample/s
Waveforms	sine, square/pulse, ramp, DC, noise, sine c exponential fall, exponential rise, cardiac	ardinal (sinc), Gaussian pulse, Lorentz,
Sine	frequency range	1 mHz to 100 MHz
	amplitude flatness (relative to 1 kHz)	≤ ±0.5 dB (meas.)
	total harmonic distortion (into 50 Ω)	
	f ≤ 10 MHz	≤ –60 dBc (meas.)
	f > 10 MHz	≤ –40 dBc (meas.)
	nonharmonic spurious	–75 dBc (meas.)
Square/pulse	frequency range	1 mHz to 30 MHz
	duty cycle (if pulse width limit is not exceeded)	0.01 % to 99.99 %, 0.01 % resolution
	pulse width	≥ 16.5 ns, 0.1 ns resolution
	rise/fall time	9 ns (meas.)
	overshoot	≤ 2 % (meas.)
	jitter (cycle-to-cycle) (≥ 0.2 V (V _{pp}))	≤ 40 ps (RMS) (meas.)
Ramp (triangle, sawtooth)	frequency range	1 mHz to 1 MHz
	variable symmetry	0 % to 100 %, 0.1 % resolution
DC	level range	
	$1000 \Omega^{\circ}$	± 2.5 V
	into open circuit	±5V
	resolution	1 mV
Noise	amplitude	
	DC	0 V to 5 V (V _{pp}) (into 50 Ω),
~		0 V to 10 V (V_{pp}) (into open circuit),
		1 mV resolution
	all other waveforms	0 % to 100 % of AC signal amplitude,
		1 % resolution
- Ma	bandwidth	≥ 100 MHz
Sine cardinal (sinc)	frequency range	1 mHz to 5 MHz
Gaussian pulse	frequency range	1 mHz to 25 MHz
Lorentz	frequency range	1 mHz to 10 MHz
Exponential rise/fall	frequency range	1 mHz to 10 MHz
Cardiac	frequency range	1 mHz to 1 MHz

Arbitrary waveform generator	output of user-defined waveforms	
Waveform length		1 sample to 40 Msample on each channel
Sample rate		1 sample/s to 312.5 Msample/s
Filter bandwidth		100 MHz
Modulation		
Modulation types		amplitude modulation (AM), frequency
		modulation (FM), frequency-shift key
		modulation (FSK), pulse width modulation
		(PWM)
Carrier waveform	AM, FM, FSK	sine
	PWM	square/pulse
AM	modulation signals	sine, square, ramp (triangle) sawtooth)
	modulation frequency	1 mHz to 1 MHz
	depth	0 % to 100 %, Ø.1 % resolution
FM	modulation signals	sine, square, triangle, ramp, inverse ramp
	modulation frequency	1 mHz to 1/MHz
	frequency deviation	1 mHz to 10 MHz
FSK	modulation signal	50 % duty cycle square wave
	range of frequency 1, frequency 2	1 mHz to 100 MHz
	hop rate	1 mHz to 1 MHz
PWM	modulation signals	sine, square, ramp
	depth	0 % to 99.99 % of the duty cycle,
		0.01% resolution

-		
Frequency sweep	output of a sinusoidal waveform	with the frequency changing linearly between the start
	frequency and the stop frequenc	y within the sweep time
	waveform	ine sine
	frequency range	1 mHz to 100 MHz
	direction	up (start frequency < stop frequency)
		down (start frequency > stop frequency)
	sweep time	1 ms to 500 s

	$\langle \sim \rangle^{\circ}$	
Two-channel operation	operating modes	independent channels, coupled parameters, differential
	parameter coupling	none, frequency and/or amplitude
	relative phase	-180° to 180°, 0.1° resolution
	channel-to-charinel skew (each channel	≤ 200 ps (meas.)
	with same output amplitude)	
	channel-to-channel isolation	≥ 70 dB (meas.)
	(each channel with same output	
	amplitude)	
×	No.	
	2)	
SN/11/2		
~ <i>5/////</i> 65		

Outputs		
Connectors		BNC; on the front of the instrument
Function		on/off, inverted
Output impedance		50 Ω (nom.)
Overload protection	V _{pp} > 200 mV into open circuit	a short-circuit to ground is tolerated indefinitely, automatic shutoff in case of voltages \geq +12 V or \leq -12 V (meas.)
	V _{pp} ≤ 200 mV into open circuit	a short-circuit to ground is tolerated indefinitely, automatic shutoff in case of voltages $\ge +4$ V or ≤ -4 V (meas)
Amplitude range 9	sine, square/pulse, ramp, exponentia Gaussian, Lorentz, cardiac	l rise/fall, arbitrary waveforms, stne cardinal (sinc),
	into 50 Ω	5 mV to 5 V (V pp)
	into open circuit	$\frac{10 \text{ mV to 30 V}(V_{pp})}{10 \text{ mV to 10 V}(V_{pp})}$
	resolution	
	accuracy	±1 % at 1 kHz
DC offset range	sine, square/pulse, ramp, exponentia	
	into 50 Ω	$\pm 2.5 V (V_{pp} \le 100 \text{ mV}),$ $\pm 1.25 V (V_{pp} \le 100 \text{ mV})$
	into open circuit	$\pm 5.6 V (V_{pp} > 200 mV),$ $\pm 2.5 V (V_{pp} \le 200 mV)$
	sine cardinal (sinc): DC offset range i	
	into 50 Ω	$2.823 \text{ V to } +2.177 \text{ V } (\text{V}_{pp} = 1 \text{ V})$
	into open circuit	-5.323 V to +4.677 V (V _{pp} = 1 V)
	Gaussian, Lorentz: DC offset range is	
	into 50 Ω	$-3.000 \text{ V to } +2.000 \text{ V } (\text{V}_{pp} = 1 \text{ V})$
	into open circuit	$-5.500 \text{ V to } +4.500 \text{ V (V}_{pp} = 1 \text{ V)}$
	cardiac: DC offset range is signal am	, FF ,
	into 50 Ω	-2.814 V to +2.186 V (V _{pp} = 1 V)
	into open circuit	-5.314 V to $+4.686$ V (V _{pp} = 1 V)
	resolution	1 mV
	accuracy	\pm (1 % of control + (0.5 % of amplitude) + 2 mV)
Frequency accuracy		$ \Delta f \le [$ (timebase accuracy) × (nominal frequency) + 1.1 µHz] (calc.) (timebase accuracy, see Horizontal system)

⁹ Amplitude is the sum of the AC amplitude and the noise amplitude.

R&S[®]MXO5-K31 power analysis

5 firmware with
es (SMPS) and
ality at an al power, apparent power, factor and frequency, crest and current
4th harmonic of the y, precompliance)-3-2 (A, B, C, D), ID-1399, max. limit
on of the
on of input offset

R&S[®]MXO5-K36 frequency response analysis

Frequency response analysis (req	uires R&S [®] MXO5-B6 option)	
Stimulus	frequency mode	single sweep or repeated sweep
	frequency range	10 mHz to 100 MHz
	amplitude mode	fixed or amplitude profile
	amplitude level	10 mV to 10 V into high Z
	· · · ·	5 mV to 5 V into 50 Ω
Input and output sources		channel 1, channel 2, channel 3,
		channel 4
Number of test points		10 points to 500 points per decade
Measurement		dual pair of tracking gain and phase
	\bigcirc \circ	cursors
Diagram types	manually changeaple vertical window size	parallel display of result window and input
		and output signal view
Result table		navigation and export functions
Scaling	during and after test	auto scale and manual scaling and
		positioning

0 R&S®MXO5-K510 low speed serial buses

I ² C decoding Protocol configuration	()) (bit rate	auto detected
Trigger	source (clock and data)	any input channel or logical channel
	trigger event setup	start, stop, restart, missing ACK, address. data, address + data
	address setup	7 bit or 10 bit address (value in hex or binary); read, write or either; condition =, ≠, ≥, ≤, in range, out of range
	data setup	data pattern up to 8 byte (hex or binary); condition =, ≠; offset within frame in range from 0 byte to 4095 byte
Decode	source (clock and data)	any input channel, logical channel
	display type	decoded bus, tabulated list
	color coding	frame, start/restart, address (read/write), data, ACK/NACK, stop, error
	address and data format	hex, decimal, octal, binary, ASCII

SPI decoding		
Protocol configuration	type	2-wire, 3-wire and 4-wire SPI
	bit rate	auto detected
	bit order	LSB first, MSB first
	word size	4/8/12/16/20/24/28/32 bit
	frame condition	CS, timeout
	polarity (MOSI, MISO, CS, CLK)	active high, active low
	phase (CLK)	first edge, second edge
Trigger	source (MOSI, MISO, CS, CLK)	any input channel or logical channel
	bit rate	up to 50 Mbps
	trigger event setup	start of frame, end of frame, MOSI, MISO
	data setup	data pattern up to 32 bit (hex or binary);
		condition =, ≠; offset within frame in range
		from 0 bit to 4095 bit
Decode	source (MOSI, MISO, CS, CLK)	any input channel, logical channel
	display type	decoded bus, tabulated list
	color coding	frame, word, error
	data format	hex, decimal, octal, binary, ASCII

UART/RS-232/RS-422/RS-485 d	ecoding	
Protocol configuration	bit rate	300 bps to 20 Mbps
	signal polarity	ide low, idle high
	number of bits	5 bit to 9 bit
	bit order	SB first, MSB first
	parity	odd, even, mark, space, none
	stop bit	1, 1.5 or 2
	end of packet	timeout, none
Trigger	source (TX and RX)	any input channel or logical channel
	trigger event setup	start bit, packet start, data, parity error,
		stop error, break condition
	data setup	data pattern (hex, decimal, octal, binary or
		ASCII); condition =, \neq ; offset within packet
		in range 0 word to 4095 words
Decode	source (TX and RX)	any input channel, logical channel
	display type	decoded bus, tabulated list
	color coding	packet, data payload, start error, parity
		error, stop error
	data format	hex, decimal, octal, binary, ASCII

data format

R&S®MXO5-K520 automotive protocols

Trigger	bit rate nominal bit rate FD data rate XL data rate sampling point device list source trigger event setup identifier setup FD bits	100 kbps to 1 Mbps 100 kbps to 15 Mbps 100 kbps to 15 Mbps 30 % to 90 % within bit period; independent settings for nominal bit FD data rate and XL data rate associate frame identifier with symmetry ID, load DBC file context any input channel or logical channel start of frame, frame type, identifier identifier + data, error condition (and combination of CRC error, bit stuffier error, form error and ACK error) identifier type (standard or extended)	nbolie el er, ny
Trigger	FD data rate XL data rate sampling point device list source trigger event setup identifier setup	100 kbps to 15 Mbps 100 kbps to 15 Mbps 30 % to 90 % within bit period; independent settings for nominal bit FD data rate and XL data rate associate frame identifier with syml ID, load DBC file content any input channel or origical channel start of frame, frame type, identifier identifier + data, error condition (and combination of CRC error, bit stuffier error, form error and ACK error)	nboli el er, ny
Trigger	XL data rate sampling point device list source trigger event setup identifier setup	100 kbps to 15 Mbps 100 kbps to 15 Mbps 30 % to 90 % within bit period; independent settings for nominal bit FD data rate and XL data rate associate frame identifier with syml ID, load DBC file content any input channel or origical channel start of frame, frame type, identifier identifier + data, error condition (and combination of CRC error, bit stuffier error, form error and ACK error)	nboli el er, ny
Trigger	sampling point device list source trigger event setup identifier setup	100 kbps to 15 Mbps 30 % to 90 % within bit period; independent settings for nominal bit FD data rate and XL data rate associate frame identifier with syml ID, load DBC file content any input channel or origical channel start of frame, frame type, identifier identifier + data, error condition (an combination of CRC error, bit stuffi error, form error and ACK error)	nboli el er, ny
Trigger	device list source trigger event setup identifier setup	30 % to 90 % within bit period; independent settings for nominal bit FD data rate and XL data rate associate frame identifier with syml ID, load DBC file content any input channel or origical channel start of frame, frame type, identifier identifier + data, error condition (an combination of CRC error, bit stuffi error, form error and ACK error)	nboli el er, ny
Trigger	device list source trigger event setup identifier setup	independent settings for nominal of FD data rate and XL data rate associate frame identifier with syml ID, load DBC file content any input channel or origical channel start of frame, frame type, identifier identifier + data, error condition (an combination of CRC error, bit stuffi error, form error and ACK error)	nboli el er, ny
Trigger	source trigger event setup identifier setup	associate frame identifier with syml ID, load DBC file context any input channel or logical channel start of frame, frame type, identifier identifier + data, error condition (an combination of CRC error, bit stuffi error, form error and ACK error)	el r, ny
Trigger	trigger event setup identifier setup	any input channel or logical channel start of frame, frame type, identifier identifier + data, error condition (an combination of CRC error, bit stuffi error, form error and ACK error)	er, ny
	identifier setup	start of frame, frame, type, identifier identifier + data, error condition (an combination of CRC error, bit stuffi error, form error and ACK error)	er, ny
	FD bits	condition $=, \neq, \geq$, \leq , in range, out of	
	1 0 010	FDF, BRS and ESI (0, 1, X)	
	XL setup	SDT, VCID, AF; condition =, ≠, ≥, ≤ in range, out of range	≤,
	data setup	data pattern up to 8 byte (hex, deci octal, binary or ASCII); condition =,	
Decode	source	any input channel, logical channel	
	display type	decoded bus, tabulated list	
	color coding	start of frame, identifier, DLC, ADS VCID, AF, data payload, CRC, end	d of
		frame, error frame, overload frame, error, bit stuffing error	e, CF
	data format	hex, decimal, octal, binary, ASCII, symbolic	
LIN decoding			
Protocol configuration	version	1.3, 2.x or SAE J602; mixed traffic	
		supported	is
	bit rate	1 kbps to 20 Mbps	
Trigger	bit rate source trigger event setup	1 kbps to 20 Mbps any input channel or logical channe start of frame (sync break), identifie	el er,
Trigger	source	1 kbps to 20 Mbps any input channel or logical channel start of frame (sync break), identifie identifier + data, wake-up frame, er condition (any combination of chec	el er, rror cksu
Trigger	source trigger event setup	1 kbps to 20 Mbps any input channel or logical channel start of frame (sync break), identifie identifier + data, wake-up frame, er condition (any combination of chec error, parity error and sync field err	el er, rror cksu ror)
Trigger	source	1 kbps to 20 Mbps any input channel or logical channel start of frame (sync break), identifier identifier + data, wake-up frame, er condition (any combination of chec error, parity error and sync field err range from 0d to 63d; condition =, start	el er, rror cksu ror)
Trigger	source trigger event setup identifier setup	1 kbps to 20 Mbps any input channel or logical channel start of frame (sync break), identifier identifier + data, wake-up frame, er condition (any combination of chec error, parity error and sync field err range from 0d to 63d; condition =, sin range, out of range	el er, rror cksu ror) ≠, ≥
	source trigger event setup identifier setup data setup	1 kbps to 20 Mbps any input channel or logical channel start of frame (sync break), identifier identifier + data, wake-up frame, er condition (any combination of chec error, parity error and sync field err range from 0d to 63d; condition =, sin range, out of range data pattern up to 8 byte (hex, deciorctal, binary or ASCII); condition =, sin range, out of range	el er, rror cksu ror) ≠, ≥
Trigger	source trigger event setup identifier setup data setup source	1 kbps to 20 Mbps any input channel or logical channel start of frame (sync break), identifier identifier + data, wake-up frame, er condition (any combination of chec error, parity error and sync field err range from 0d to 63d; condition =, sin range, out of range data pattern up to 8 byte (hex, deci octal, binary or ASCII); condition =, any input channel, logical channel	el er, rror cksu ror) ≠, ≥
	source trigger event setup Identifier setup data setup source display type	1 kbps to 20 Mbps any input channel or logical channel start of frame (sync break), identifie identifier + data, wake-up frame, er condition (any combination of chec error, parity error and sync field err range from 0d to 63d; condition =, s in range, out of range data pattern up to 8 byte (hex, deci octal, binary or ASCII); condition =, any input channel, logical channel decoded bus, tabulated list	el er, rror cksu ror) ≠, ≥
	source trigger event setup identifier setup data setup source	1 kbps to 20 Mbps any input channel or logical channel start of frame (sync break), identifier identifier + data, wake-up frame, er condition (any combination of chec error, parity error and sync field err range from 0d to 63d; condition =, sin range, out of range data pattern up to 8 byte (hex, deci octal, binary or ASCII); condition =, any input channel, logical channel	el er, rror cksu ror) ≠, ≥

Ordering information

Designation R&S®MXO 5 Series, base models	Туре	Order No.
Oscilloscope, 350 MHz, 4 channels	R&S [®] MXO 54	1802.1008 04
Oscilloscope, 100 MHz, 8 channels	R&S®MXO 58	1802.1008K08
Base unit (including standard accessories: 700 MHz passive probe (10:1) per channel, power cord)		
Choose your bandwidth upgrade		
Upgrade of R&S [®] MXO 54 to 500 MHz bandwidth	R&S [®] MXO5-B245	1802.0676.02
Upgrade of R&S [®] MXO 54 to 1 GHz bandwidth	R&S®MXO5-B2410	1802.0682.02
Upgrade of R&S [®] MXO 54 to 2 GHz bandwidth	R&S®MXO5-B2420	1802.0699.02
Upgrade of R&S [®] MXO 58 to 200 MHz bandwidth	R&S®MXO5-B282	1802.0701.02
Upgrade of R&S [®] MXO 58 to 350 MHz bandwidth	R&S®MXO5-B283	1802.0718.02
Upgrade of R&S [®] MXO 58 to 500 MHz bandwidth	R&S®MXO5-B285	1802.0724.02
Upgrade of R&S [®] MXO 58 to 1 GHz bandwidth	R&S [®] MXO5-B2810	1802.0730.02
Upgrade of R&S®MXO 58 to 2 GHz bandwidth	R&S [®] MXO5-B2820	1802.0747.02
Choose your options		
Mixed signal option for R&S [®] MXO 5 Series with 16 digital channels	R&S®MX05-B1	1802.0660.02
Arbitrary waveform generator, 100 MHz, 2 analog channels	R&S®MXO5-B6	1802.0753.02
Additional M.2 SSD	R&S [®] MXO5-B19	1803.0205.02
Memory option 1 Gpoints	R&S®MXO5-B110	1803.0211.02
Low speed serial triggering and decoding (I ² C/SPI/UART/RS-232/RS-422/RS-485)	R&S [®] MXO5-K510	1802.1243.02
Automotive serial triggering and decoding (CAN/CAN FD/CAN XL/LIN)	R&S®MXO5-K520	1802.1920.02
Power analysis	R&S [®] MXO5-K31	1802.0799.02
Frequency response analysis	R&S [®] MXO5-K36	1802.1943.02
Application bundle, consists of the following options: R&S®MXO5-K510, R&S®MXO5-K520, R&S®MXO5-K31, R&S®MXO5-K36, R&S®MXO5-B6	R&S [®] MXO5-PK1	1803.0257.02
Choose your additional probes		
Single-ended passive probes	1	
700 MHz, 10 MΩ, 10:1, 400 V, 9.5 pF, 2.5 mm	R&S [®] RT-ZP11	1803.0005.02
500 MHz, 10 MΩ, 10:1, 400 V, 9.5 pF, 2.5 mm	R&S [®] RT-ZP10	1409.7550.00
500 MHz, 10 MΩ, 10:1, 300 V, 10 pF, 5 mm	R&S [®] RT-ZP05S	1333.2401.02
<u>38 MHz, 1 MΩ, 1:1, 55 V, 39 pF, 2.5 mm</u>	R&S [®] RT-ZP1X	1333.1370.02
Active broadband probes: single-ended		4000 0045 00
1.0 GHz, 10:1, 1 MΩ, BNC interface	R&S®RT-ZS10L	1333.0815.02
1.0 GHz, active, 1 MΩ, Rohde & Schwarz probe interface 1.0 GHz, active, 1 MΩ, R&S [®] ProbeMeter, micro button,	R&S [®] RT-ZS10E R&S [®] RT-ZS10	1418.7007.02 1410.4080.02
Rohde & Schwarz probe interface	Rad RI-2010	1410.4060.02
1.5 GHz, active, 1 MΩ, R&S [®] ProbeMeter, micto button,	R&S [®] RT-ZS20	1410.3502.02
Rohde & Schwarz probe interface	Ras RT-2320	1410.3302.02
1.0 GHz, active, differential, 1 M Ω , R&S [®] ProbeMeter, micro button, incl. 10:1 external attenuator, 1 M Ω , 70 V DC, 46 V AC (peak), Rohde & Schwarz probe interface	R&S [®] RT-ZD10	1410.4715.02
1.5 GHz, active, differential, 1 MQ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface Power rail probe	R&S [®] RT-ZD20	1410.4409.02
2.0 GHz, 1:1, 50 kΩ, ±0.85 V, ±60 V offset, Rohde & Schwarz probe interface High voltage probes: passive	R&S [®] RT-ZPR20	1800.5006.02
250 MHz, 100:1, 100 MΩ, 850 V, 6.5 pF	R&S®RT-ZH03	1333.0873.02
400 MHz, 100:1, 100 MX, 800 V, 8.5 pr	R&S®RT-ZH10	1409.7720.02
400 MHz, 100 1, 50 MQ, 1000 V, 7.5 pF	R&S®RT-ZH11	1409.7737.02
High voltage propes, differential		1400.1101.02
200 MHz, 250 1/25,1, 5 MΩ, 750 V (peak), 300 V CAT III,	R&S [®] RT-ZHD07	1800.2307.02
Rohde & Schwarz probe interface 100 MHz, 500 1/50:1, 10 MΩ, 1500 V (peak), 1000 V CAT III,	R&S [®] RT-ZHD15	1800.2107.02
Rohde & Schwarz probe interface		
200/MPz 500:1/50:1, 10 MΩ, 1500 V (peak), 1000 V CAT III, Ronde & Schwarz probe interface	R&S [®] RT-ZHD16 R&S [®] RT-ZHD60	1800.2207.02
/100 MHz, 1000:1/100:1, 40 MΩ, 6000 V (peak), 1000 V CAT III,		1800.2007.02

Designation	Туре	Order No.
Current probes		
20 kHz, AC/DC, 0.01 V/A and 0.001 V/A, ±200 A and ±2000 A, BNC interface	R&S [®] RT-ZC02	1333.0850.02
100 kHz, AC/DC, 0.1 V/A, 30 A, BNC interface	R&S [®] RT-ZC03	1333.0844.02
2 MHz, AC/DC, 0.01 V/A, 500 A (RMS), Rohde & Schwarz probe interface	R&S [®] RT-ZC05B	1409.8204 02
10 MHz, AC/DC, 0.01 V/A, 150 A (RMS), BNC interface	R&S [®] RT-ZC10	1409.7750K02
10 MHz, AC/DC, 0.01 V/A, 150 A (RMS), Rohde & Schwarz probe interface	R&S [®] RT-ZC10B	1409.8210.02
50 MHz, AC/DC, 0.1 V/A, 30 A (RMS), Rohde & Schwarz probe interface	R&S [®] RT-ZC15B	1409.8227.02
100 MHz, AC/DC, 0.1 V/A, 30 A (RMS), BNC interface	R&S [®] RT-ZC20	1409.7766K02
100 MHz, AC/DC, 0.1 V/A, 30 A (RMS), Rohde & Schwarz probe interface	R&S [®] RT-ZC20B	1409.8233.02
120 MHz, AC/DC, 1 V/A, 5 A (RMS), BNC interface	R&S [®] RT-ZC30	1409.7772K02
EMC near-field probe	()	YO)
Probe set for E and H near-field measurements, 30 MHz to 3 GHz	R&S®HZ-15	1147.2736.02
Logic probe ¹⁰		
400 MHz logic probe, 8 channels	R&S [®] RT-ZL04	1333.0721.02
Probe accessories		
Accessory set for R&S [®] RT-ZP11 passive probe (2.5 mm probe tip)	R&S [®] RT-ZA1	1409.7566.00
Probe power supply for R&S [®] RT-ZC10/-ZC20/-ZC30	R&S [®] RT-ZA13	1409.7789.02
External attenuator 10:1, 2.0 GHz, 1.3 pF, 60 V DC,	R&S [®] RT-ZA15	1410.4744.02
42.4 V AC (peak), for R&S [®] RT-ZD20/-ZD30 probes		
Probe pouch for the logic probes	R&S [®] R∕T-ZĂ19	1335.7875.02
Power deskew and calibration test fixture	R&S®RT-ZF20	1800.0004.02
3D positioner with central tensioning knob for easy clamping and positioning of probes (span width: 200 mm, clamping range: 15 mm)	R&S®RT-ZA1P	1326.3641.02
Bipod probe positioner	R&S [®] RT-ZA29	1801.4803.02
Choose your accessories	\mathcal{I}	
Rackmount kit, for R&S®MXO 5 Series with 8 HU	R&S [®] ZZA-MXO5	1802.3181.02
Front cover	R&S [®] MXO5-Z1	1803.0240.02
Soft case (W × H × D: 550 mm × 300 mm × 340 mm)	R&S [®] MXO5-Z3	1803.0228.02
Transit case (W × H × D: 613 mm × 478 mm × 337 mm)	R&S [®] MXO5-Z4	1803.0234.02
VESA adapter	R&S [®] MXO5-Z7	1803.0457.02
VESA mount (compatible with standard 100 mm × 100 mm pattern)	Choose industry standar	rd mounts
	according to FDMI MIS-I M4x10 screws	D, up to 14 kg with

¹⁰ The R&S[®]MXO5-B1 mixed signal option contains two R&S[®]RT-ZL04 logic probes.

Warranty		
Base unit		1 year
All other items 11		1 year
Options		
Extended warranty, one year	R&S [®] WE1	Contact your local
Extended warranty, two years	R&S [®] WE2	Rohde & Schwarz sales office.
Extended warranty with calibration coverage, one year	R&S [®] CW1	
Extended warranty with calibration coverage, two years	R&S [®] CW2	
Extended warranty with accredited calibration coverage,	R&S [®] AW1	
one year		
Extended warranty with accredited calibration coverage,	R&S [®] AW2	
two years		

Extended warranty with a term of one and two years (WE1 and WE2)

Repairs carried out during the contract term are free of charge ¹². Necessary calibration and adjustments carried out during repairs are also covered.

Extended warranty with calibration coverage (CW1 and CW2)

Enhance your extended warranty by adding calibration coverage at a package price. This package ensures that your Rohde & Schwarz product is regularly calibrated, inspected and maintained during the terms of the contract. It includes all repairs ¹² and calibration at the recommended intervals as well as any calibration carried out during repairs proption upgrades.

Extended warranty with accredited calibration (AW1 and AW2)

Enhance your extended warranty by adding accredited calibration coverage at a package price. This package ensures that your Rohde & Schwarz product is regularly calibrated under accreditation, inspected and maintained during the term of the contract. It includes all repairs ¹² and accredited calibration at the recommended intervals as well as any accredited calibration carried out during repairs or option upgrades.

The terms HDMI and HDMI High-Definition Multimedia Interface, and the HDMI Logo are trademarks or registered trademarks of HDMI Licensing, LLC in the United States and other countries.

¹¹ For options installed, the remaining base unit warranty applies if longer than 1 year. Exception: all batteries have a 1 year warranty.

¹² Excluding defects caused by incorrect operation or handling and force majeure. Wear-and-tear parts are not included.

101

rese

Service at Rohde & Schwarz You're in great hands

- ► Worldwide
- Local and personalized
- Customized and flexible
- Uncompromising quality
 Long-term dependability

Rohde & Schwarz

The Rohde & Schwarz technology group is among the trailblazers when it comes to paving the way for a safer and connected world with its leading solutions in test & measurement, technology systems and networks & cybersecurity. Founded more than 85 years ago, the group is a reliable partner for industry and government customers around the globe. The independent company is headquartered in Munich, Germany and has an extensive sales and service network with locations in more than 70 countries.

www.rohde-schwarz.com

Sustainable product design

- Environmental compatibility and eco-footprint
- Energy efficiency and low emissions
- ► Longevity and optimized total cost of ownership



Certified Environmental Management ISO 14001

Rohde & Schwarz training

www.training.rohde-schwarz.com

Rohde & Schwarz customer support

www.rohde-schwarz.com/support



83.8196.22 03.00 PDP/PDW 1 en